

Silicon or sapphire

Which substrate will meet the yield and cost requirements for micro LED displays?

2020 World Display Industry Conference, 21st November 2020, online meeting, presented by Alexander Loesing, co-founder of ALLOS

Outline

1. Introduction to ALLOS

- 2. Silicon or sapphire for mass production of micro LED
- 3. ALLOS' 1 bin[®] LED epiwafer technology for high yield and cost-competitive mass production
- 4. Conclusion



ALLOS* is a leader in GaN-on-Si with <u>17 years</u> successful track-record





ALLOS' value proposition is to license and transfer turn-key GaN-on-Si epiwafer technology and IP





With only few runs any active layers can be integrated on ALLOS' buffer – also all colors: Blue / green / red



* This can be from ALLOS' customer or a third party (e.g. by licensing the LED stack)



Outline

- 1. Introduction to ALLOS
- 2. Silicon or sapphire for mass production of micro LED
- 3. ALLOS' 1 bin[®] LED epiwafer technology for high yield and cost-competitive mass production
- 4. Conclusion



Silicon or sapphire? Why ask this question?

- ✓ GaN-on-sapphire is <u>the</u> material of choice for (conventional) LEDs
- Most micro LED displays demonstrated today use GaN-on-sapphire

BUT Micro LEDs are Monolithically **Required yield** much smaller and integrated displays levels make thus more difficult need diameter to quantum leap of to make match CMOS yield necessary Cost is hugely 'Square packing' Micro LEDs require driven by yield in thin-film designs becomes a crucial processing steps (substrate removal) cost driver after epi





- → Micro LEDs are <u>super tiny</u> (and thinner) and difficult to handle
- The much smaller size requires improved processing skills, cleanroom and sophisticated silicon industry level processing tools
- The amount of chips *explodes*: On a single 200 mm micro LED wafer you have
 > 600 million micro LED chips of 5 x 5 μm² which requires new approaches



Micro LEDs require thin-film designs (substrate removal)

GaN-on-Si enables low cost & high yield thin-film LEDs

Lateral or flip-chip LED*



- → With conventional chip designs it is difficult and costly to achieve the desired thinness
- → The aspect ratio makes use of thin-film LED chips necessary for micro LEDs

Vertical or thin-film (flip-chip) LED*



- → Laser-lift-off on sapphire will not achieve the required yield, in particular on ≥ 200 mm
- → Bonding ALLOS' GaN-on-Si epiwafers is easier because of low, precisely controlled bow
- → Vertical and TFFC designs favor use of silicon for easier substrate removal with high yield

* Drawings not to scale and dimensions are examples of possible micro LED chips (thin-film vertical or thin-film flip-chip [TFFC])









300

> 9

128

> 40 %

displays per area

Public | 2020 WDIC | 11

Required yield levels make quantum leap of yield necessary

The yield challenge in numbers...

- A standard 4K UHD display has 3,840 x 2,160 pixels (= 8,294,400)
- For an RGB display you thus need more than 24,800,000 micro LED chips

Relevant vield*	equals amount of chins failing	
Relevant yield		Even a Six Sigma
90.00000 %	2,488,320.00	
95.00000 %	1,244,160.00	= 99.99 % defect-
99.00000 %	248,832.00	free process will
99.90000 %	24,883.20	require 2,488
99.99000 %	2,488.32	chips to be
99.99900 %	248.83	repaired on
99.99990 %	24.88	a 4K UHD display
99.99999 %	2.49	
99.99900 % 99.99990 % 99.99999 %	248.83 24.88 2.49	repaired on a 4K UHD display

→ Uniformity of epiwafers needs to be improved drastically
 → It becomes essential to use the high yield of silicon processing lines

* Combined yield of all processes including on-wafer yield, LED chip making yield, transfer yield, etc.



Cost is hugely driven by yield in processing steps after epi

Uniform epiwafers improve the cost and yield of the entire production chain



1bin® technology:

- Delivers world leading wavelength uniformity which is the most critical LED yield contributor
- Enables up to 300 mm diameter to reduce cost in the following LED production steps
- Provides high crystal quality that is needed to guarantee excellent LED efficiency

 200 and 300 mm diameter epiwafers from ALLOS enable the use of low cost and high yielding lines for LED chip processing (e.g. depreciated silicon semiconductor line

 Epiwafers fulfil CMOS incoming wafer quality criteria Easy bonding of transferwafer to LED wafer thanks to low bow

 Low cost and high yielding removal of silicon substrate (no laser lift off needed)

- Large 200 and 300 mm wafers return much more chips per wafer area when using transfer stamps
- Realize the vision of 100 % LED chip yield to enable mass transfer and minimize repair: Main contributors are 1 bin[®] wavelength uniformity and the high yield level of silicon semiconductor lines
- Cost benefits gained throughout the entire manufacturing chain enable the mass production of micro LED displays

ALLOS' 1 bin[®] epiwafer technology enhances yield and reduces cost





Outline

- 1. Introduction to ALLOS
- 2. Silicon or sapphire for mass production of micro LED
- 3. ALLOS' 1 bin[®] LED epiwafer technology for high yield and cost-competitive mass production
- 4. Conclusion



Essential requirements for micro LED achieved by ALLOS

High crystal quality

Same low defect level as on GaN-on-sapphire: TDD ~2 x 10⁸ cm⁻²

= Performance

Large diameter and CMOS ready

- 🖌 200 mm and 300 mm diameter
- < 30 µm bow for 725 µm (200 mm) and 775 µm (300 mm) thickness
- No cracks, no residual strain

= Low-cost



Excellent wavelength uniformity

- Requires perfect conditions for MQW growth...
- ... which cannot be achieved on sapphire - especially not at similar wafer diameters...
- ... and needs to be repeatable

= High yield

* Protected by ALLOS' IP; active layers can be the same structure as used by customer for GaN-on-sapphire



Record-breaking emission uniformity < 0.6 nm is achieved on 200 mm GaN-on-Si micro LED epiwafer



Result from customer project on Veeco Propel in February 2019



Excellent reproducibility for emission wavelength uniformity



13 repetition runs with average STDEV of wavelength uniformity of 0.79 nm and all points below 1 nm (STDEV of average value is 0.095 nm)

Result from customer project using the same recipe on Veeco Propel in January 2020



Low V_f and high P_{out} are on a par with GaN-on-sapphire LEDs



@ 350 mA	V _{f1} (@10 μA)	V _{f2} (Volt)	V _r (Volt)	Ι _r (μΑ)	P _{out} (a. u.)	W _d (nm)	P _{out} to mass production GaN-on- sapphire LED
GaN-on-Si LED	2.21	3.12	15.24	0.06	69.0	451.7	97 %

Result from customer project on Veeco K465i already in 2015, using customer's mass-production GaN-on-sapphire LED structure on ALLOS' GaN-on-Si buffer



ALLOS' GaN-on-Si epiwafer technology is the key enabler for 1 bin[®] low-cost, high-yield micro LED production



Excellent emission uniformity: < 0.6 nm sigma **High crystal quality:** TDD ~2 x 10⁸ cm⁻² **Existing MQW from on-sap**phire can be easily integrated Flat wafers: < 30 µm bow for 725 µm thickness (200 mm) No cracks, no residual strain Large diameter: 200 mm and 300 mm



300 mm GaN-on-Si growth is <u>NOT</u> the future anymore!



ALLOS' technology is already scaled to 300 mm GaN-on-Si!



Outline

- 1. Introduction to ALLOS
- 2. Silicon or sapphire for mass production of micro LED
- 3. ALLOS' 1 bin[®] LED epiwafer technology for high yield and cost-competitive mass production

4. Conclusion



Conclusion: GaN-on-Si is the material of choice for micro LED

Requirement for micro LED	GaN-on-sapphire	GaN-on-Si with ALLOS' quality		
Micro LEDs are much smaller and thus more difficult to make Tiny size demands new processing skills	Conventional LED processing is insufficient	Opens door for silicon industry process skills		
Micro LEDs require thin-film designs (substrate removal) Micro LEDs need substrate removal	Laser-lift-off and bonding cause yield issues	High yield substrate removal and bonding		
Monolithically integrated displays need diameter to match CMOS	100 mm standard size and only max. 150 mm size	Same size and bow like CMOS driver wafer		
^{'Square packing'} becomes a crucial cost driver AR displays per wafer	Limited by available wafer size	40 % cost saving / more displays with 300 mm		
Required yield levels make quantum leap of yield necessary failure need <u>high yield</u>	Conventional LED processing is insufficient	Record uniformity and use of silicon industry yield		
Cost is hugely driven by yield in processing steps after epi Low cost is possible but only with high yield	Low cost but yield is low causing high cost	Super uniform epiwafer increases yield downstream		

JS

Semiconductors

CSindustry awards

Thank you very much for your attention!



al@allos-semiconductors.com





Alexander_Loesing

ALLOS Semiconductors GmbH Alexander Loesing, Co-founder and CMO Breitscheidstrasse 78 01237 Dresden, Germany

Office: +49-351-212 937-10 Fax: +49-351-212 937-99 Visit us http://www.allos-semiconductors.com

Follow us

https://www.linkedin.com/company/allos-semiconductors-gmbh https://twitter.com/ALLOSsemi